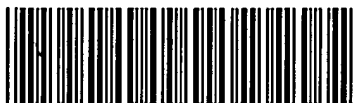


Search Notes

Application/Control No.

10/694,215

Examiner

Tianjie Chen

Applicant(s)/Patent under
Reexamination

AOISHI ET AL.

Art Unit

2656

SEARCHED

Class	Subclass	Date	Examiner
360	133	1/27/2006	TJ
720	725	1/27/2006	TJ

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East Reports	1/27/2006	TJ